



Test Report

MERITEK ELECTRONICS CORPORATION
11824 HAMDEN PLACE
SANTA FE SPRINGS, CA 90670
USA

Report No : CE/2004/42151B
Date : 2004/05/06
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The following merchandise was(were) submitted and identified by the client as :


Type of Product : POLYMERIC POSITIVE TEMPERATURE COEFFICIENT
THERMISTOR (RESETTABLE FUSE)
Style/Item No : DIP TYPE / MPTR 30V SERIES
Information Need to be : MIXED BODY & COATING
Printed on Report
Sample Received : 2004/04/29.
Testing Date : 2004/04/29 TO 2004/05/06

Test Result

PART NAME NO.1 : PLEASE REFER TO THE SAMPLE CARD(S).

Test Item(s):	Unit	Method	MDL	Result				
				NO.1				
Chromium VI (Cr+6)	ppm	As per US EPA 7196A and US EPA 3060A.	2	N.D.				
Cadmium (Cd)	ppm	ICP-AES After As per EN 1122, Method B:2001 or other acid digestion.	2	N.D.				
Mercury (Hg)	ppm	ICP-AES After As per US EPA 3052 or other acid digestion.	2	N.D.				
Lead (Pb)	ppm	ICP-AES After As per US EPA 3050B or other acid digestion.	2	72.1				

NOTE : (1) N.D. = Not detected.(<MDL)
(2) ppm = mg/kg
(3) MDL= Method Detection Limit


Daniel Yeh, M.R. / Operation Manager
Signed for and on behalf of
SGS TAIWAN LTD.

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